Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,056	LIN, CHUN-WEI	
Examiner	Art Unit	
Anna Gofman	1771	

SEARCHED			
Class	Subclass	Date	Examiner
442	59	3/24/2006	AG
428	412	3/24/2006	AG
442	149	3/24/2006	AG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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			<del>                                     </del>

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Class search	3/24/2006	AG
Derwent search	3/24/2006	AG
Inventor search	3/24/2006	AG
Text Search	3/24/2006	AG